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Emergent photovoltage on SmB₆ surface upon bulk-gap evolution revealed by pump-and-probe photoemission spectroscopy

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Recent studies suggest that an exemplary Kondo insulator SmB₆ belongs to a new class of topological insulators (TIs), in which non-trivial spin-polarized metallic states emerge on surface upon the formation of Kondo hybridization gap in the bulk. Remarkably, the bulk resistivity reaches more than 20 Ω cm at 4 K, making SmB₆ a candidate for a so-called bulk-insulating TI. We here investigate optical-pulse responses of SmB₆ by pump-and-probe photoemission spectroscopy. Surface photovoltage effect is observed below ~90 K. This indicates that an optically-active band bending region develops beneath the novel metallic surface upon the bulk-gap evolution. The photovoltaic effect persists for >200 μs, which is long enough to be detected by electronics devices, and could be utilized for optical gating of the novel metallic surface.

Topological insulators (TIs) are promising spin-electronic device materials because they exhibit spin-polarized metallic states on surface¹. The surface of TI is topologically constrained to become a two-dimensional massless Dirac electron system that shows novel properties such as high mobility and suppression of backscattering. Extensive research is being pursued to extract the surface-dominated conduction by realizing a so-called intrinsic TI, in which the bulk shows insulating behavior^{2–5}; Prototypical Bi-based TIs such as Bi₂Se₃ and Bi₂Te₃, which are proven to possess the topological surface states, are still conductive in the bulk due to off stoichiometry².

Recently, SmB₆ was theoretically predicted to be a TI that has the bulk-insulating property^{6,7}. SmB₆ has long been known as an exemplary heavy-fermion semiconductor, or Kondo insulator (KI)^{8–10}. It is a mixed valence compound, in which the occupation number of Sm 4*f* orbital lies between 5 and 6^{11,12}. On cooling, the magnetic moment due to localized *f* electrons vanishes and an activation-type semiconductivity sets in below ~50 K, which are the characteristics of KI governed by strong electron correlations^{13,14}. The resistivity attains more than 20 Ωcm, but unlike in an insulator, it levels off below 4 K, which has been a mystery since the 1960's^{15–19}. Transport studies after the theoretical proposal suggest that the low-temperature residual conductivity can be the manifestation of topologically metallic surface^{20–22}. Spectroscopic studies have reported residual surface states within the Kondo hybridization gap, and the compatibility to the topological KI picture is discussed^{23–31}.

Regarding that SmB₆ possesses the bulk-insulating property and novel metallic surface that could be of topological nature, it is interesting to search for the response of SmB₆ as a bulk insulator that can functionalize the novel metallic surface. Here, using photoemission spectroscopy implemented by a pump-and-probe method, we investigate the response of SmB₆ to optical pulses. We find that surface photovoltage (SPV) emerges below ~90 K accompanied by the evolution of the hybridization gap. SPV occurs because of the optically-active surface band bending region that develops on the edge of semiconductors^{32–34}. The SPV duration exceeds 200 μs, which is good news from opto-electronic application points of view, because it is long enough to be detected by electronic devices. We also report on the pump-induced variation of the SPV and the electronic recovery dynamics, both of which exceeding 100 ps.



Results

Figure 1(a) shows valence-band spectra of SmB_6 recorded at 10 K. Here, the sample was driven into a periodic steady state by repetitively irradiating the 170-fs pump pulses of 1.5 eV at the interval of 4 μs (250-kHz repetition); see the schematic in Fig. 1(a). The pump-probe delay was set to $t = -1$ ps, so that the probing by the 5.9 eV pulse was done just before the arrival of the pump, or equivalently, 4 μs after the arrival of the previous pump. As the pump power p was increased, the spectrum consisting of $H_{7/2}$ and $H_{5/2}$ peaks located at -20 and -150 meV, respectively, shifted into the occupied side (lower energies) with negligible modification in the spectral shape; see Fig. 1(a), in which the spectrum recorded at $p = 46 \mu\text{J}/\text{cm}^2$ nicely overlaps to that recorded without pump after some shift in energy. The pump-induced shift δ as a function of p is plotted in Fig. 1(b). For the derivation of δ , see Methods. The δ - p curve shows the tendency of saturation with increasing p . Through fitting by a function $\delta = \delta_0(1 - e^{-p/p_0})$, the saturation value δ_0 at 10 K is estimated to be 4.6 meV (p_0 is a fitting parameter). We did not observe the broadening of the spectrum in the pump-power range investigated herein, indicating that the heating of the sample due to the irradiation of the pump beam was negligibly small.

The pump-induced shift of the spectrum is attributed to the SPV effect^{32–34}, which is similar to the photovoltaic effect occurring in the interfacial band-bending region in solar cells and photo-diodes. SPV usually occurs because of the photo-induced relaxation of the surface band bending. Therefore, the pump-induced shift into the occupied side indicates that the bulk is slightly n -type doped to exhibit an upward surface band bending on the edge, and that this bending relaxes under the pump-beam irradiation; see the schematic in Fig. 1(d). Concerning that the SPV is at most the size of the band bending, it is reasonable that the saturation value δ_0 is comparable to the activation-gap size of 3 meV and is smaller than the hybridization gap of 15–20 meV reported to date³⁵. We can exclude the possibility of photo-induced increase of the band bending, or the photovoltage inversion, because it can occur only when the photon energy of the irradiation is less than the band gap³⁶. We can also exclude the charging effect as the origin of the pump-induced shift, because the pump generated negligibly small amount of multi-photon photoelectrons compared to the amount of photoelectrons generated by the probe. Therefore, if the charging effect existed, it should have been already prominent just by the probe-beam irradiation. Moreover, the charging-induced shift do not have reasons to exhibit saturation behavior as seen in the δ - p curve presented in Fig. 1(b). Signatures of possible pump-induced variations in the surface states were not observed in the spectrum, which would have manifested as changes additional to the photovoltaic shift of the states within the surface band bending region.

Next, we show the temperature dependence of the photovoltaic shift. In Fig. 1(c), we show spectra recorded with and without pump at various temperatures. Here, p and t were fixed to 29 $\mu\text{J}/\text{cm}^2$ and -1 ps, respectively. As the temperature was increased, the photovoltaic shift diminished and became negligible above ~ 90 K ($\equiv T^*$). T^* nicely coincides to the temperature around which the hybridization gap diminishes²⁹. This shows that the photovoltaic effect emerges upon the hybridization-gap opening and coupled evolution of the surface band bending. δ as a function of temperature is plotted in Fig. 1(d). The δ - T curve is concave ($\partial^2\delta/\partial T^2 > 0$), and is contrasted to the gap evolution in a second-order transition. This may reflect the crossover nature of the gap opening in the periodic Anderson model, in which the temperature-dependent renormalization follows $\propto -\log T$ behavior^{14,37}.

The photovoltaic shift observed at $t = -1$ ps, or 4 μs after the previous pulse, indicates that the duration of the photovoltage is exceeding 4 μs . In order to obtain in-depth information, we investigated the repetition-rate (interval-time τ) dependence of the pump-induced shift. To this end, we repetitively deflected out the pulse out

of the 250 kHz laser by using a pulse picker and used the deflected pulse in the pump-and-probe measurement. In this way, we can set the interval time τ to 4 $\mu\text{s} \times 2^n$ ($n = 0, 1, \dots, 6$) without changing the intensity per pulse. As shown in Figs. 2(a) and 2(b), the pump-induced shift monotonically decreased as τ was increased. This is in agreement with the picture that the remaining SPV responses to the preceding pulses became small as the interval of the pulses was increased. However, δ did not decrease exponentially with τ , and the SPV duration exceeded 200 μs . This shows that the SPV response induced by the intense laser pulse is in the saturation regime, so that δ is not a simple addition of the individual responses to each pulse. Note, the SPV is limited by the amount of the surface band bending built in at equilibrium. The saturation behavior is also noticed by the fact that the SPV is still sizable even when the average pump power (p multiplied by the repetition rate) is reduced to 1/64 [Fig. 2(b)].

Next, we investigate the initial dynamics induced by the pump pulse in the femto-to-picoseconds. Here, we find ultrafast electron redistribution on arrival of the pump, subsequent recovery of the electronic system that persists for >100 ps, and gradual change of the photovoltage after ~ 100 ps, as we describe below.

Figures 3(a) and 3(b) show photoemission spectra at various pump-probe delays displayed in linear- and logarithmic-scale plots, respectively. Here, T , p , and τ were 10 K, 29 $\mu\text{J}/\text{cm}^2$, and 4 μs , respectively. On arrival of the pump ($-0.3 < t < 0$ ps), the spectral intensity increases in the unoccupied side. Seen in the logarithmic-scale plot [Fig. 3(b)], we discern a plateau feature in the unoccupied side, which is similar to those observed in the time-resolved photoemission spectra of Au³⁸ and graphite³⁹. This indicates that a non-thermal electron distribution (non-Fermi-Dirac distribution) is realized on arrival of the pump. Then, the plateau feature turns over into an exponential tailing at $0 < t < 0.2$ ps [Fig. 3(b)]. This indicates that the electronic distribution turned into Fermi-Dirac distribution function, and the electronic temperature became definable. After 0.2 ps, the slope of the exponential tailing gradually recovers to the value before the pump with the time scale exceeding 100 ps. This indicates that the cooling of the electronic system occurred on the >100 -ps time scale. The exponential tailing is not exceeding the energy scale of $k_B T^* \sim 30$ meV (k_B is the Boltzmann constant), so that the electronic temperature is estimated to be less than T^* at >0.2 ps. This indicates that the pump did not collapse the hybridization gap or that the gap had already recovered by 0.2 ps.

In Fig. 3(a), we also observe that the spectra are gradually shifted into the unoccupied side at ≥ 100 ps. This is attributed to the pump-induced variation of the photovoltage in the periodic steady state. SPV varies after the photo-excited electrons and holes drift into opposite directions in the surface-band-bending region, and therefore, a delay can exist in the SPV response^{32–34}. The shift of the spectra into the unoccupied side indicates that the amount of band bending is increasing at ≥ 100 ps. In the SPV dynamics in semiconductors^{33,34}, there are fast (sub nano-second) and slow (over 10 nano-second) components in the SPV recovery. The fast component is known to be sensitive to surface conditions and surface states³⁴. It is also reported that when photo-induced depopulation of surface states occur, photovoltage can increase the amount of band bending rather than decreasing it^{32,34,36}. Therefore, the pump-induced variation of SPV at >100 ps may be involving interesting dynamics in the surface states of SmB_6 , although the detailed mechanism is not clear at present.

At $T = 130$ K [Fig. 3(c)], the pump-induced shift at >100 ps was hardly detected, while the cooling of the electronic system was still taking place for >100 ps (see later). The absence of the shift at >100 ps is consistent with the fact that the pump-induced photovoltaic effect occurs only below the characteristic temperature T^* as shown in Fig. 1. The pump-induced change in the spectrum at >0.2 ps occurs in a wider energy range set by the thermal broadening of the spectra, see the $4k_B T$ energy scale displayed in Fig. 3(c). The pump-induced changes occurring farther into the unoccupied

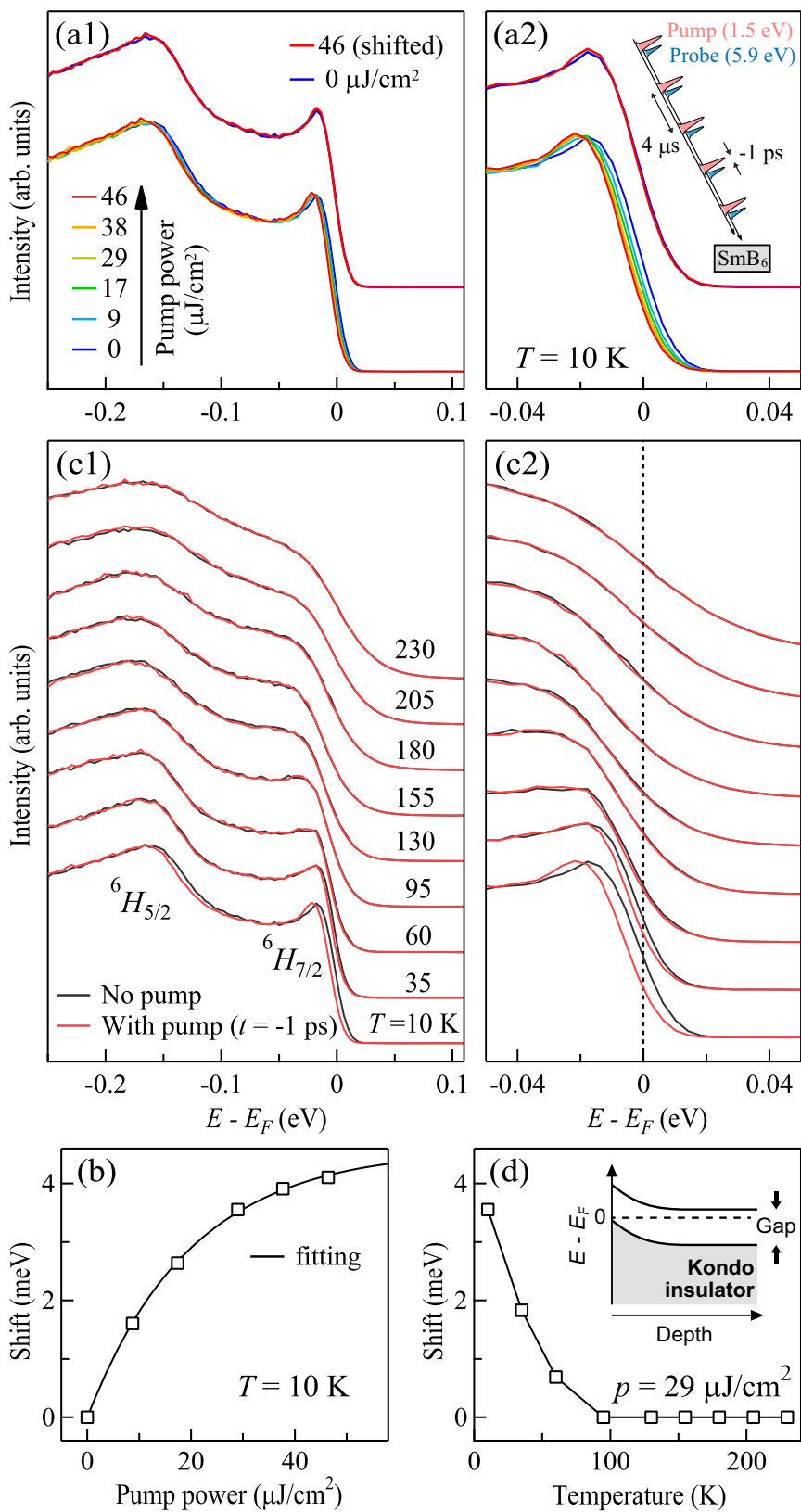


Figure 1 | Surface photovoltage effect. (a1, a2) Pump-power dependence of the photovoltaic shift of the spectra recorded at $T = 10$ K. Spectra recorded at $p = 0$ and $46 \mu\text{J}/\text{cm}^2$ are also displayed with the latter shifted in energy to overlap the former. Inset to (a2) schematically shows the pump and probe pulses arriving repetitively on the sample with the pump-probe delay of -1 ps. (b) Pump-power dependence of the photovoltaic shift at $T = 10$ K. (c1, c2) Temperature dependence of the photovoltaic shift. Spectra recorded with and without pump at various temperatures are displayed. Pump power was $p = 29 \mu\text{J}/\text{cm}^2$, and the pump-probe delay was set to $t = -1$ ps. (d) Temperature dependence of the shift induced by $p = 29 \mu\text{J}/\text{cm}^2$. Schematic of the upward surface band bending is also shown. Error bars in (b) and (d) are smaller than the marker size.

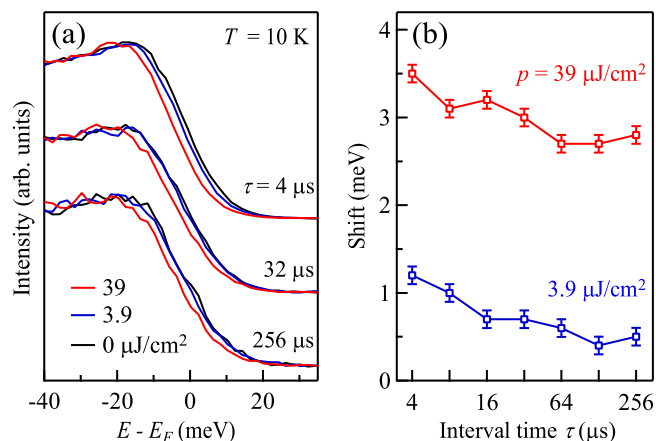


Figure 2 | Duration of the surface photovoltage effect. (a) Spectra recorded under the repetitive pump pulses arriving at the intervals of $\tau = 4$, 32, and 256 μs . Spectra were recorded at $T = 10$ K and $t = -1$ ps. (b) Photovoltaic shift δ as functions of the interval time τ . The error bars represent typical standard deviations.

side at higher temperatures can also be seen in Fig. 3(d), in which the intensity maps of the pump-induced change $\Delta I(\omega, t) = I(\omega, t) - I_0(\omega)$ and excess electronic energy distribution $\omega \Delta I(\omega, t)$ at various temperatures are displayed in the upper and lower panels, respectively [$I_0(\omega)$ is the average of the spectrum recorded at $-3 < t < -0.33$ ps]. For the full set of pump-and-probe photoemission spectra taken at various temperatures, see a supplementary movie file in which the frames of the spectra in linear and logarithmic scale, and that of the difference spectra are shown.

Discussion

In general, the recovery dynamics after the pump is considered to be very different between metals and semiconductors. In metals, the recovery time of the electronic system is typically of 1 ps^{38,40,41}, while

strong electron correlations may delay the recovery to some extent⁴². When the electronic dynamics is coupled to the lattice degrees of freedom, the recovery can be bottlenecked around ~ 1 ps, because the slow heat dissipation from the lattice may govern the recovery thereafter^{39,43}. In gapped systems such as semiconductors and superconductors, the recovery time can exceed 100 ps because the electron-hole annihilation across the gap emits some boson modes that re-excites electron-hole pairs^{44–47}; in effect, the recovery is slowed.

Having outlined above, we look into the indications of the slow electronic recovery as evidenced by the slope of the spectral tailing not fully recovered even at 100 ps. First, the long recovery time observed at $T < T^*$ indicates that, even though there are in-gap states, the photo-excited electron-hole pairs are protected from fast recombinations of ~ 1 ps seen in metals. This is in accord with the picture that the in-gap states are localized on surface, and that they are spatially separated from the electron-hole pairs in the bulk. Next, the recovery persisting for >100 ps even at $T > T^*$ may be reflecting the crossover nature of the hybridization gap, so that the semiconductor characteristics in the recovery may still remain above T^* . Alternatively, the lattice degrees of freedom may be slowing the recovery. In order to see whether a bottleneck

exists in the recovery, we plot $\Delta U_e(t) \equiv \int_{\omega > 0} \omega \Delta I(\omega, t) d\omega$ at various temperatures in Fig. 3(e). $\Delta U_e(t)$ is a good measure of how the excess electronic energy dissipates with time (This is a good measure even at $T < T^*$ if $t \lesssim 100$ ps, because in that time region, the photovoltaic shift is still small). Clearly, there is a crossover in the electronic recovery at ~ 0.5 ps. This is the bottleneck effect, which is usually attributed to the thermalization between electronic and coupled phonon systems in a two-temperature model scheme^{40,43}, although the microscopic validation of the model as well as the mechanism of the bottleneck are still under discussion^{39,48}. The relaxation after ~ 0.5 ps can be reflecting the slow heat transfer from the slightly hot electronic system to the slightly cool lattice⁴⁸. Whatever the origin may be, the bottleneck at ~ 0.5 ps observed

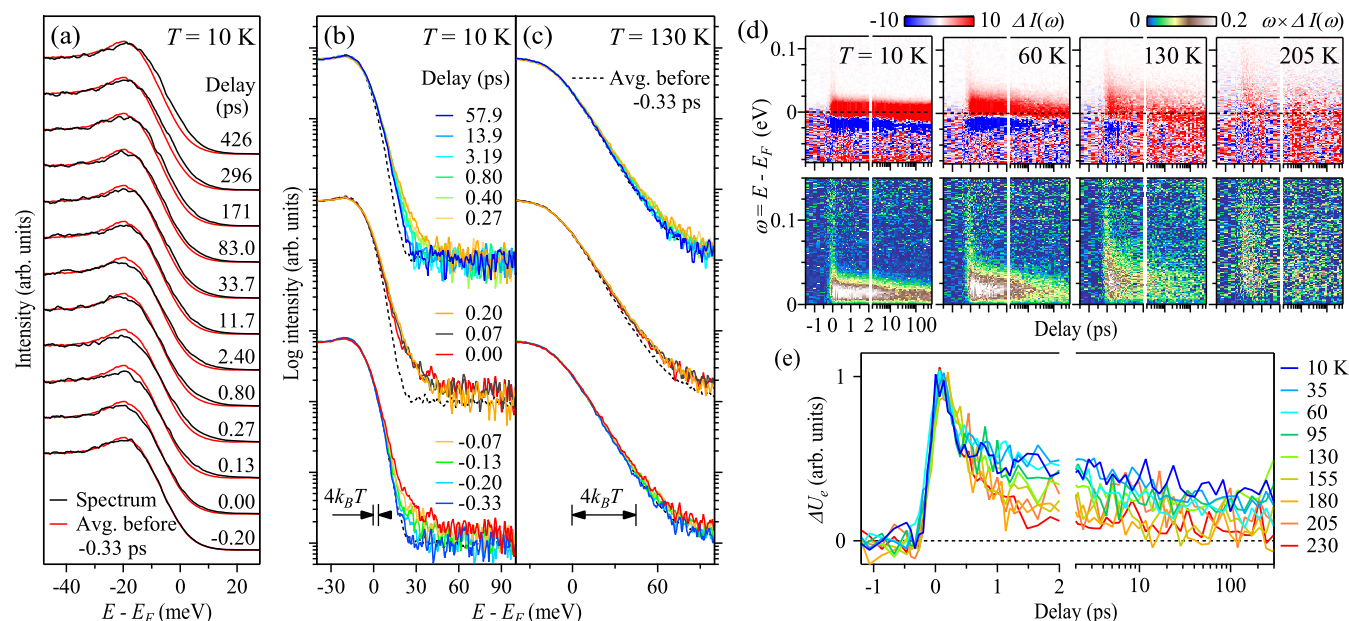


Figure 3 | Initial dynamics induced by the pump pulse. (a) Spectra recorded at $T = 10$ K, $p = 29 \mu\text{J}/\text{cm}^2$, and $\tau = 4 \mu\text{s}$ at several delays. The averaged spectrum before -0.33 ps is also overlaid on each spectrum. The shift of the spectra into the unoccupied side becomes prominent at $t \gtrsim 100$ ps, which is attributed to the variation of the surface photovoltage induced by the pump pulse. (b, c) Spectra in a logarithmic scale plot at $T = 10$ and 130 K, respectively. The energy scale of $4k_B T$ is also displayed. (d) Pump-induced difference of the spectrum (upper panels) and excess-energy distributions (lower panels) mapped in the $\omega - t$ plane ($\omega \equiv E - E_F$) at various temperatures. (e) Dissipation of the excess-electronic energy (see, text) at various temperatures.



also at $T > T^*$ shows that the slowing of the recovery is not unique to temperatures below T^* .

The electronic recovery time exceeding 100 ps was also observed in a pump-and-probe photoemission study of Bi-based TI that has bulk resistivity as high as $\sim 4 \Omega \text{ cm}$ at 4 K⁴⁹. In contrast to the present study, however, SPV effect was not reported therein. Our study thus demonstrates the co-existence of the optically active band bending region and novel metallic state on the edge of the highly bulk resistive SmB_6 . The SPV effect can be utilized as an opto-electronic device function such as optical gating of the novel metallic surface for extracting the spin currents, which would be readily detected by means of electronic devices concerning its long duration exceeding 200 μs .

Methods

Single crystalline samples of SmB_6 were grown by floating-zoned method using a 4-xenon-lamp image furnace, which was also used for single crystal growth of KlYbB_{12} ⁵⁰. Samples of $2 \times 2 \times 6 \text{ mm}^3$ in size cut out along [001] were cleaved in the spectrometer at the base pressure of 5×10^{-11} Torr. Time-resolved photoemission spectroscopy was done in a pump-and-probe configuration⁵¹. The laser pulse (1.5 eV and 170 fs duration) delivered from a Ti:Sapphire laser system operating at 250 kHz repetition (Coherent RegA 9000) was split into two: One pulse is used as a pump, and the other was up-converted into 5.9 eV and used as a photoemission source (probe). The repetition rate of the laser pulses was discretely changeable by using a pulse picker consisting of an acoustic optical modulator. The pump-and-probe delay t was controlled by changing the optical path length of the pump beam line. The delay origin $t = 0$ and time resolution (300 fs) were determined by recording the pump-probe photoemission signal of graphite attached next to the sample⁵¹. The diameters of the pump and probe beams on the sample position were 0.5 and 0.3 mm, respectively. The Fermi energy E_F and the energy resolution (18 meV) were determined by recording the Fermi cutoff of gold in electrical contact to the sample and the VG Scientia R4000 analyzer.

The datasets of the spectra presented in Figs. 1(a), 1(c), 2(a) and 3(a) - 3(c) were acquired via automated sequences, in which parameters such as p and t were repetitively cycled over the specified values during the acquisition. For example, the set of spectra presented in Fig. 1(a) were accumulated while cycling p from 0 to 46 $\mu\text{J}/\text{cm}^2$; for those presented in Fig. 2(a), p was cycled as $0 \rightarrow 3.9 \rightarrow 39 \mu\text{J}/\text{cm}^2$ under the respective repetition rates. In this way, we can accumulate the spectra until sufficient signal-to-noise ratio (S/N) is simultaneously achieved in the whole dataset. Such a dataset acquisition is advantageous because each of the spectrum in the raw dataset is normalized to the acquisition time and has the same S/N . This allowed us a normalization-free dataset analyses when deriving various quantities such as δ and ΔU_e . The spectral shift δ [Figs. 1(b) and 2(b)] was determined such that δ minimized $F(\delta) = \int |I(\omega - \delta) - \bar{I}(\omega)|^2 d\omega$, where $I(\omega)$ and $\bar{I}(\omega)$ are the raw spectra recorded with and without pump, respectively.

- Hasan, M. Z. & Kane, C. L. Topological insulators. *Rev. Mod. Phys.* **82**, 3045–3067 (2010).
- Ren, Z., Taskin, A. A., Sasaki, S., Segawa, K. & Ando, Y. Large bulk resistivity and surface quantum oscillations in the topological insulator $\text{Bi}_2\text{Te}_2\text{Se}$. *Phys. Rev. B* **82**, 241306 (2010).
- Taskin, A. A., Ren, Z., Sasaki, S., Segawa, K. & Ando, Y. Observation of Dirac Holes and Electrons in a Topological Insulator. *Phys. Rev. Lett.* **107**, 016801 (2011).
- Xiong, J. *et al.* Quantum oscillations in a topological insulator $\text{Bi}_2\text{Te}_2\text{Se}$ with large bulk resistivity. *Physica E: Low-dimensional Systems and Nanostructures* **44**, 917–920 (2012).
- Brahlek, M., Koirala, N., Salehi, M., Bansal, N. & Oh, S. Emergence of Decoupled Surface Transport Channels in Bulk Insulating Bi_2Se_3 Thin Films. *Phys. Rev. Lett.* **113**, 026801 (2014).
- Dzero, M., Sun, K., Galitski, V. & Coleman, P. Topological Kondo Insulators. *Phys. Rev. Lett.* **104**, 106408 (2010).
- Takimoto, T. SmB_6 : A Promising Candidate for a Topological Insulator. *J. Phys. Soc. Jpn.* **80**, 123710 (2011).
- Aeppli, G. & Fisk, Z. Kondo Insulators. *Comments Cond. Mat. Phys.* **16**, 155–165 (1992).
- Takabatake, T. *et al.* Ce- and Yb-based Kondo semiconductors. *J. Magn. Magn. Mater.* **177–181**, 277–282 (1998).
- Riseborough, P. S. Heavy fermion semiconductors. *Adv. Phys.* **49**, 257–320 (2000).
- Cohen, R. L., Eibschutz, M. & West, K. W. Electronic and Magnetic Structure of SmB_6 . *Phys. Rev. Lett.* **24**, 383–386 (1970).
- Mizumaki, M., Tsutsui, S. & Iga, F. Temperature dependence of Sm valence in SmB_6 studied by X-ray absorption spectroscopy. *J. Phys.: Conf. Ser.* **176**, 012034 (2009).
- Tahvildar-Zadeh, A. N., Jarrell, M. & Freericks, J. K. Low-Temperature Coherence in the Periodic Anderson Model: Predictions for Photoemission of Heavy Fermions. *Phys. Rev. Lett.* **80**, 5168–5171 (1998).
- Burdin, S., Georges, A. & Grepel, D. R. Coherence Scale of the Kondo Lattice. *Phys. Rev. Lett.* **85**, 1048–1051 (2000).
- Menth, A., Buehler, E. & Geballe, T. H. Magnetic and Semiconducting Properties of SmB_6 . *Phys. Rev. Lett.* **22**, 295–297 (1969).
- Kasuya, T., Takegahara, K., Fujita, T., Tanaka, T. & Bannai, E. Valence Fluctuating State in SmB_6 . *J. Phys. Colloques* **40**, C5–308 (1979).
- Allen, J. W., Batlogg, B. & Wachter, P. Large low-temperature Hall effect and resistivity in mixed-valent SmB_6 . *Phys. Rev. B* **20**, 4807–4813 (1979).
- Cooley, J. C., Aronson, M. C., Fisk, Z., and Canfield, P. C. SmB_6 : Kondo Insulator or Exotic Metal? *Phys. Rev. Lett.* **74**, 1629–1632 (1995).
- Anderson, P. W. Fermi sea of heavy electrons (a Kondo lattice) is never a Fermi liquid. *Phys. Rev. Lett.* **104**, 176403 (2010).
- Wolgast, S. *et al.* Low-temperature surface conduction in the Kondo insulator SmB_6 . *Phys. Rev. B* **88**, 180405 (2013).
- Kim, D. J. *et al.* Surface Hall Effect and Nonlocal Transport in SmB_6 : Evidence for Surface Conduction. *Sci. Rep.* **3**, 3150 (2013).
- Kim, D. J., Xia, J. & Fisk, Z. Topological surface state in the Kondo insulator samarium hexaboride. *Nature Commun.* **13**, 466–470 (2014).
- Miyazaki, H., Hajiri, T., Ito, T., Kunii, S. & Kimura, S.-i. Momentum-dependent hybridization gap and dispersive in-gap state of the Kondo semiconductor SmB_6 . *Phys. Rev. B* **86**, 075105 (2012).
- Zhu, Z.-H. *et al.* Polarity-Driven Surface Metallicity in SmB_6 . *Phys. Rev. Lett.* **111**, 216402 (2013).
- Neupane, M. *et al.* Surface electronic structure of the topological Kondo-insulator candidate correlated electron system SmB_6 . *Nature Commun.* **4**, 2991 (2013).
- Jiang, J. *et al.* Observation of possible topological in-gap surface states in the Kondo insulator SmB_6 by photoemission. *Nature Commun.* **4**, 3010 (2013).
- Xu, N. *et al.* Surface and bulk electronic structure of the strongly correlated system SmB_6 and implications for a topological Kondo insulator. *Phys. Rev. B* **88**, 121102 (2013).
- Frantzeskakis, E. *et al.* Kondo Hybridization and the Origin of Metallic States at the (001) Surface of SmB_6 . *Phys. Rev. X* **3**, 041024 (2013).
- Zhang, X. *et al.* Hybridization, Inter-Ion Correlation, and Surface States in the Kondo Insulator SmB_6 . *Phys. Rev. X* **3**, 011011 (2013).
- Xu, N. *et al.* Direct observation of the spin texture in SmB_6 as evidence of the topological Kondo insulator. *Nature Commun.* **5**, 4566 (2014).
- Rosler, S. *et al.* Hybridization gap and Fano resonance in SmB_6 . *Proc. Natl. Acad. Sci.* **111**, 4798–4802 (2014).
- Kronik, L. & Shapira, Y. Surface photovoltage phenomena: theory, experiment, and applications. *Surf. Sci. Rep.* **37**, 1–206 (1999).
- Tanaka, S., More, S. D., Murakami, J., Itoh, M., Fujii, Y. & Kamada, M. Surface photovoltage effects on p -GaAs (100) from core-level photoelectron spectroscopy using synchrotron radiation and a laser. *Phys. Rev. B* **64**, 155308 (2001).
- Marsi, M. *et al.* Transient charge carrier distribution at UV-photoexcited SiO_2/Si interfaces. *Phys. Rev. B* **61**, R5070–R5073 (2000).
- Gorshunov, B. *et al.* Low-energy electrostatics of SmB_6 . *Phys. Rev. B* **59**, 1808–1814 (1999).
- Gatos, H. C. & Lagowski, J. Surface Photovoltage Spectroscopy - A New Approach to the Study of High-Gap Semiconductor Surfaces. *J. Vac. Sci. Technol.* **10**, 130–135 (1973).
- Choi, H. C., Min, B. I., Shim, J. H., Haule, K. & Kotliar, G. Temperature-Dependent Fermi Surface Evolution in Heavy Fermion CeIrIn_5 . *Phys. Rev. Lett.* **108**, 016402 (2012).
- Fann, W. S., Storz, R., Tom, H. W. K. & Bokor, J. Electron thermalization in gold. *Phys. Rev. B* **46**, 13592–13595 (1992).
- Ishida, Y. *et al.* Non-thermal hot electrons ultrafastly generating hot optical phonons in graphite. *Sci. Rep.* **1**, 64 (2011).
- Allen, P. B. Theory of Thermal Relaxation of Electrons in Metals. *Phys. Rev. Lett.* **59**, 1460–1463 (1987).
- Brorson, S. D. *et al.* Femtosecond room-temperature measurement of the electron-phonon coupling constant γ in metallic superconductors. *Phys. Rev. Lett.* **64**, 2172–2175 (1990).
- Werner, P. & Eckstein, M. Relaxation dynamics of the Kondo lattice model. *Phys. Rev. B* **86**, 045119 (2012).
- Perfetti, L. *et al.* Ultrafast Electron Relaxation in Superconducting $\text{Bi}_2\text{Sr}_2\text{CaCu}_2\text{O}_{8-\delta}$ by Time-Resolved Photoelectron Spectroscopy. *Phys. Rev. Lett.* **99**, 197001 (2007).
- Rothwarf, A. & Taylor, B. N. Measurement of recombination lifetimes in superconductors. *Phys. Rev. Lett.* **3**, 27–30 (1967).
- Haight, R. & Silberman, J. A. Surface Intervalley Scattering on GaAs(110): Direct Observation with Picosecond Laser Photoemission. *Phys. Rev. Lett.* **62**, 815–818 (1989).
- Demsar, J. *et al.* Pair-Breaking and Superconducting State Recovery Dynamics in MgB_2 . *Phys. Rev. Lett.* **91**, 267002 (2003).
- Ono, S., Shima, H. & Toda, Y. Theory of photoexcited carrier relaxation across the energy gap of phase-ordered materials. *Phys. Rev. B* **86**, 104512 (2012).
- Baranov, V. V. & Kabanov, V. V. Theory of electronic relaxation in a metal excited by an ultrashort optical pump. *Phys. Rev. B* **89**, 125102 (2014).



49. Hajlaoui, M. *et al.* Tuning a Schottky barrier in a photoexcited topological insulator with transient Dirac cone electron-hole asymmetry. *Nature Commun.* **5**, 3003 (2014).
50. Iga, F., Shimizu, N. & Takabatake, T. Single crystal growth and physical properties of Kondo insulator YbB₁₂. *J. Magn. Mater.* **177–181**, 337–338 (1998).
51. Ishida, Y. *et al.* Time-resolved photoemission apparatus achieving sub-20-meV energy resolution and high stability. *Rev. Sci. Instrum.* **85**, 123904 (2014).

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Author contributions

Y.I. and T.O. performed the experiments in assist of T.S. and M.O.; T.O. and Y.I. made the repetition-rate of the laser system changeable under the direction by Y.K.; F.I. grew

high-quality single crystals under the supervision of T.T.; Y.I. analyzed the data and wrote the manuscript; S.S. supervised the project; All authors discussed the results and commented on the manuscript.

Additional information

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